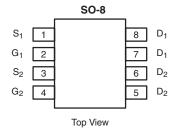


SI4204DY-VB Datasheet **Dual N-Channel 20 V MOSFET**

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A)	Q _g (Typ.)		
20	0.0038 at V _{GS} = 10 V	19.8 ^a	14.5		
20	0.0047 at V _{GS} = 4.5 V	17.3 ^a	14.5		



FEATURES

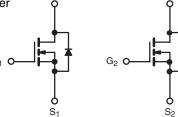
- Halogen-free According to IEC 61249-2-21 Definition
- Trench Power MOSFET
- 100 % R_g Tested 100 % UIS Tested
- Compliant to RoHS Directive 2002/95/EC



COMPLIANT HALOGEN FREE

APPLICATIONS

- DC/DC Converter
- Fixed Telecom
- Notebook PC



N-Channel MOSFET

N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS T _A =					
		Symbol	Limit	Unit	
Drain-Source Voltage	V_{DS}	20	V		
Gate-Source Voltage	V_{GS}	± 20			
	T _C = 25 °C		19.8		
Continuous Drain Current (T 150 °C)	T _C = 70 °C	,	15.9		
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	I _D	15.5 ^{b, c}		
	T _A = 70 °C		12.2 ^{b, c}		
Pulsed Drain Current (10 μs Pulse Width)	·	I _{DM}	50	^	
Source-Drain Current Diode Current	T _C = 25 °C	2.7	Α		
Source-Drain Current blode Current	T _A = 25 °C	I _S	1.6 ^{b, c}	•	
Pulsed Source-Drain Current		I _{SM}	50		
Single Pulse Avalanche Current		I _{AS}	20		
Single Pulse Avalanche Energy	lanche Energy L = 0.1 mH		20		
	T _C = 25 °C		3.25	- I	
Maximum Dawar Dissination	T _C = 70 °C		2.10	W	
Maximum Power Dissipation	T _A = 25 °C	P _D	2.0 ^{b, c}		
	T _A = 70 °C		1.25 ^{b, c}	•	
Operating Junction and Storage Temperature Range	T _J , T _{stg}	- 55 to 150	°C		

THERMAL RESISTANCE RATINGS							
Parameter		Symbol	Тур.	Max.	Unit		
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 s	R _{thJA}	45	62.5	°C/W		
Maximum Junction-to-Foot (Drain)	Steady-State	R _{thJF}	29	38	O/ VV		

Notes:

- a. Based on T_{C} = 25 $^{\circ}C.$
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 10 s.
- d. Maximum under steady state conditions is 120 °C/W.

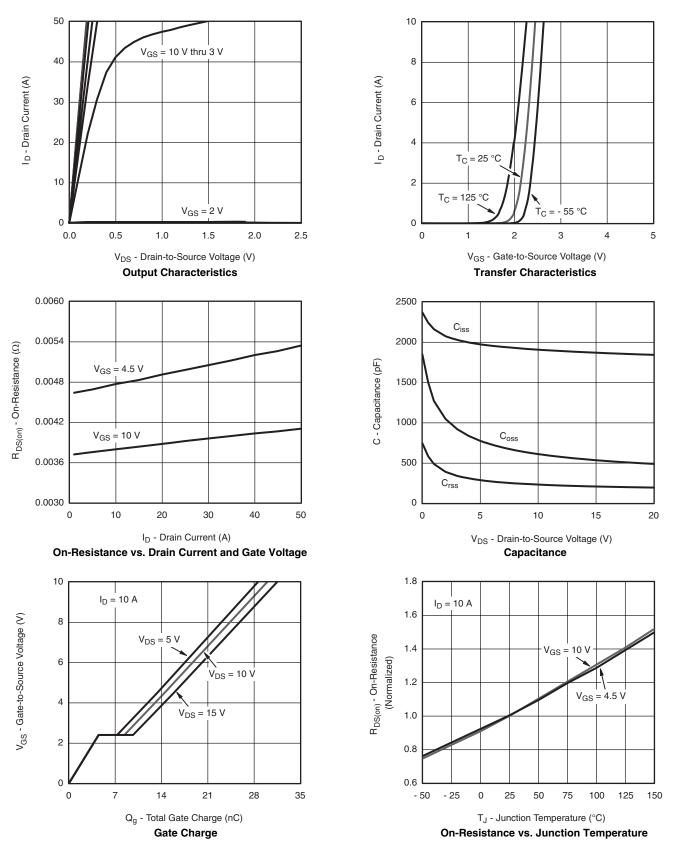


Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static	•			'			
Drain-Source Breakdown Voltage	V_{DS}	V _{GS} = 0 V, I _D = 250 μA	20			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = 250 μA		20		m\//°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA		- 5.8		mV/°C	
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1.0		2.4	V	
Gate-Body Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			100	nA	
Zoro Coto Voltago Drain Current	I _{DSS}	V _{DS} = 20 V, V _{GS} = 0 V			1		
Zero Gate Voltage Drain Current		$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			10	μΑ	
On-State Drain Current ^b	I _{D(on)}	V _{DS} = 5 V, V _{GS} = 10 V	20			Α	
Drain Sauras On State Besietanes	В	V _{GS} = 10 V, I _D = 10 A		0.0038		Ω	
Drain-Source On-State Resistance ^b	R _{DS(on)}	V _{GS} = 4.5 V, I _D = 8 A		0.0047			
Forward Transconductance ^b	9 _{fs}	V _{DS} = 15 V, I _D = 10 A		50		S	
Dynamic ^a				•			
Input Capacitance	C _{iss}			2110		pF	
Output Capacitance	C _{oss}	V _{DS} = 10 V, V _{GS} = 0 V, I _D = 1 MHz		926			
Reverse Transfer Capacitance	C _{rss}]		235			
Tabal Cada Obania	Qg	V _{DS} = 10 V, V _{GS} = 10 V, I _D = 10 A		30	45		
Total Gate Charge				14.5	22	nC	
Gate-Source Charge	Q_{gs}	$V_{DS} = 10 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 10 \text{ A}$		4.5			
Gate-Drain Charge	Q _{gd}]		3.9			
Gate Resistance	R_{g}	f = 1 MHz	0.4	1.4	2.8	Ω	
Turn-On Delay Time	t _{d(on)}			8	16		
Rise Time	t _r	$V_{DD} = 10 \text{ V, R}_{L} = 1 \Omega$		15	30	1	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 10 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		24	45		
Fall Time	t _f]		9	18		
Turn-On Delay Time	t _{d(on)}			18	35	ns	
Rise Time	t _r	$V_{DD} = 10 \text{ V, R}_{L} = 1 \Omega$		24	45		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 10 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		26	50		
Fall Time	t _f]		13	26		
Drain-Source Body Diode Characteristi	cs			'			
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			2.7		
Pulse Diode Forward Current ^a	I _{SM}				50	Α	
Body Diode Voltage	V _{SD}	I _S = 3 A		0.70	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			20	40	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	N-Channel		10	20	nC	
Reverse Recovery Fall Time	t _a	I _F = 10 A, dl/dt = 100 A/μs, T _J = 25 °C		11		_	
Reverse Recovery Rise Time	t _b	j t		9		nS	

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

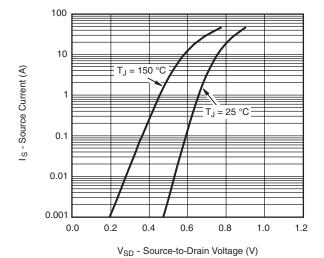


TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

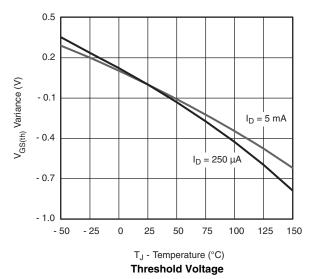


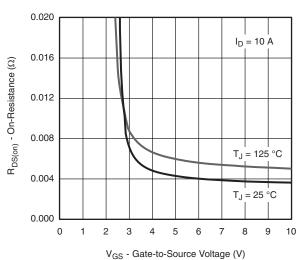


TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

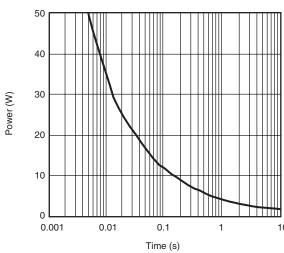


Source-Drain Diode Forward Voltage

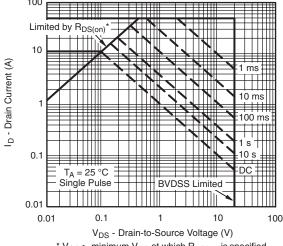




On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power, Junction-to-Ambient

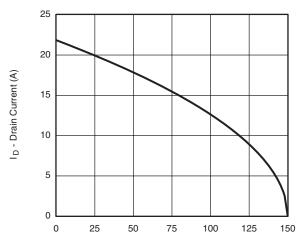


* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

Safe Operating Area, Junction-to-Ambient

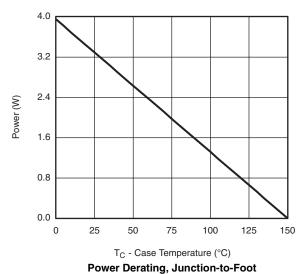


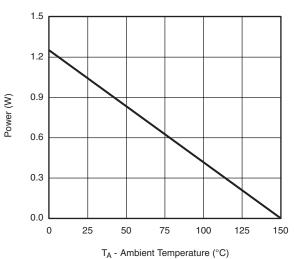
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



T_C - Case Temperature (°C)

Current Derating*





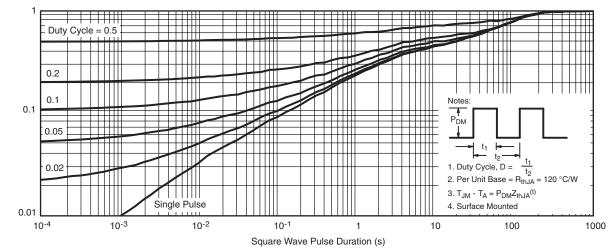
Power Derating, Junction-to-Ambient

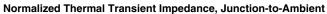
^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

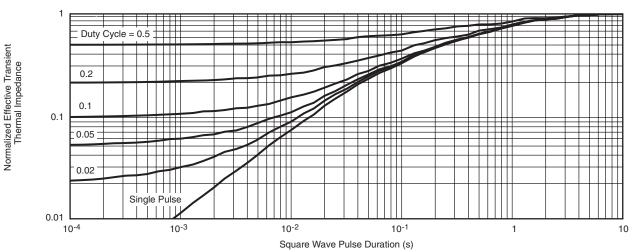
Normalized Effective Transient Thermal Impedance



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



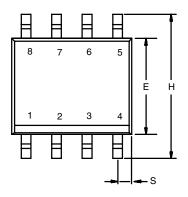


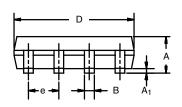


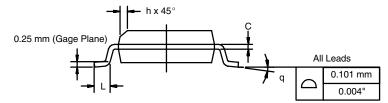
Normalized Thermal Transient Impedance, Junction-to-Foot



SOIC (NARROW): 8-LEAD JEDEC Part Number: MS-012







	MILLIMETERS		INC	HES		
DIM	Min	Max	Min	Max		
Α	1.35	1.75	0.053	0.069		
A ₁	0.10	0.20	0.004	0.008		
В	0.35	0.51	0.014	0.020		
С	0.19	0.25	0.0075	0.010		
D	4.80	5.00	0.189	0.196		
Е	3.80	4.00	0.150	0.157		
е	1.27	1.27 BSC		0.050 BSC		
Н	5.80	6.20	0.228	0.244		
h	0.25	0.50	0.010	0.020		
L	0.50	0.93	0.020	0.037		
q	0°	8°	0°	8°		
S	0.44	0.64	0.018	0.026		
ECN: C-06527-Rev. I, 11-Sep-06						

DWG: 5498



RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)



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